


<b><i>Search Notes</i></b>  	<b>Application/Control No.</b>  10840108	<b>Applicant(s)/Patent Under Reexamination</b>  WEEL, MARTIN
	<b>Examiner</b>  SAKET K DAFTUAR	<b>Art Unit</b>  2451

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SEARCH NOTES		
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Updated Limited Keyword on EAST PGPUB, USPAT, IBM-TDB	1/25/2011	SKD

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